DFN 3x3



# NVTFS5C471NLTAG-VB Datasheet N-Channel 40V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>f</sup>	Q <sub>g</sub> (TYP.)			
40	0.013 at V <sub>GS</sub> = 10 V	28	6.8 nC			
40	0.015 at V <sub>GS</sub> = 4.5 V	25	0.6110			

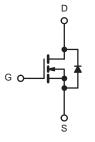
#### **FEATURES**

- Trench Gen IV power MOSFET
- $\bullet$  Tuned for the lowest  $R_{DS}$   $Q_{oss}$  FOM
- $\bullet$  100 %  $R_g$  and UIS tested
- $Q_{qd} / Q_{qs}$  ratio < 1 optimizes switching characteristics



#### **APPLICATIONS**

- Synchronous rectification
- DC/DC converters
- · Motor drive switch
- Battery and load switch



N-Channel MOSFET

Bottom View		
	Тор	View
	S [ 1 •	8 D
	S    ² S    3	7    D 6    D
Pin 1	G [ 4	5 ] D
	Bottom View	Bottom View  Top 1  S [ 1 •  S [ 2   S [ 3   G [ 4   ]

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>A</sub> = 25 °C, unless otherwise noted)				
PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	$V_{DS}$	40	V	
Gate-Source Voltage		$V_{GS}$	± 20	V
	T <sub>C</sub> = 25 °C		30	
Continuous Drain Comment (T. 150 °C)	T <sub>C</sub> = 70 °C		25.3	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	11.4 <sup>a, b</sup>	
	T <sub>A</sub> = 70 °C	1	9.2 <sup>a, b</sup>	Δ.
Pulsed Drain Current (t = 100 μs)		I <sub>DM</sub>	70	A
On the contract of the Date Divide On the Contract	T <sub>C</sub> = 25 °C	Is	19	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C		2.2 <sup>a, b</sup>	
Single Pulse Avalanche Current	l 0.1 mll	I <sub>AS</sub>	11	
Single Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	6	mJ
	T <sub>C</sub> = 25 °C		23	
Martin or Brown Biretouther	T <sub>C</sub> = 70 °C	] _	14.8	14/
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2.6 <sup>a, b</sup>	W
	T <sub>A</sub> = 70 °C		1.7 <sup>a, b</sup>	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	00
Soldering Recommendations (Peak tempera		260	°C	

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum Junction-to-Ambient <sup>a, e</sup> t ≤ 10 s		R <sub>thJA</sub>	38	48	°C/W	
Maximum Junction-to-Case (Drain) Steady state		R <sub>thJC</sub>	4.3	5.4	C/VV	

#### **Notes**

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- e. The DFN 3 x 3 EP is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- d. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- e. Maximum under steady state conditions is 94 °C/W.
- f. Based on  $T_C = 25$  °C.



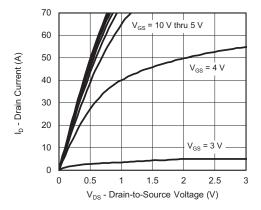
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static			•				
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	40	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A	-	22.1	-		
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA	-	-5.1	-	mV/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.0	-	2.5	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = +20 \text{ V} / -16 \text{ V}$	-	-	± 100	nA	
Zoro Cata Valtaga Drain Current		V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V	-	-	1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 55 ^{\circ}\text{C}$	-	-	10	μA	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> ≥ 5 V, V <sub>GS</sub> = 10 V	10	-	-	Α	
Drain-Source On-State Resistance <sup>a</sup>	В	$V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$	-	0.013	-		
Diain-Source On-State nesistance "	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 5 \text{ A}$	-	0.015	-	Ω	
Forward Transconductance <sup>a</sup>	g <sub>fs</sub>	$V_{DS} = 10 \text{ V}, I_{D} = 5 \text{ A}$	-	52	-	S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>		-	1800	-	pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	155	-		
Reverse Transfer Capacitance	$C_{rss}$		-	20	-		
C <sub>rss</sub> /C <sub>iss</sub> Ratio			-	0.018	0.036		
Total Cata Charge	Q <sub>g</sub>	$V_{DS} = 20 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$	-	14.2	22	nC	
Total Gate Charge			-	6.8	11		
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 20 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 5 \text{ A}$	-	3	-		
Gate-Drain Charge	$Q_{gd}$		-	1.5	-		
Output Charge	Q <sub>oss</sub>	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$	-	6.5	-		
Gate Resistance	$R_{g}$	f = 1 MHz	0.4	2	4	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>		-	16	30		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 20 V, $R_L$ = 4 $\Omega$	-	56	110		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$	-	13	25		
Fall Time	t <sub>f</sub>		-	27	55		
Turn-On Delay Time	t <sub>d(on)</sub>		-	7	15	ns	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 20 V, $R_L$ = 4 $\Omega$	_	22	45		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 5$ Å, $V_{GEN} = 10$ V, $R_g = 1$ $\Omega$	-	13	25		
Fall Time	t <sub>f</sub>		-	8	15		
Drain-Source Body Diode Characteristic	cs						
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	-	-	19	^	
Pulse Diode Forward Current	I <sub>SM</sub>		-	-	3 0	Α	
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 5 A, V <sub>GS</sub> = 0 V	-	0.8	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>		-	20	40	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 5 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C		10	20	nC	
Reverse Recovery Fall Time	t <sub>a</sub>			10.5	-	,	
Reverse Recovery Rise Time	t <sub>b</sub>			9.5	-	ns	

#### Notes

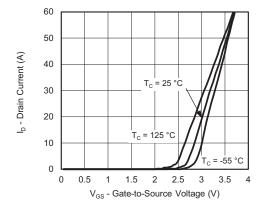
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

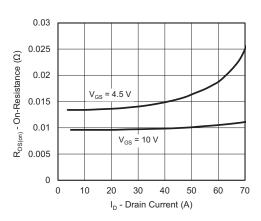




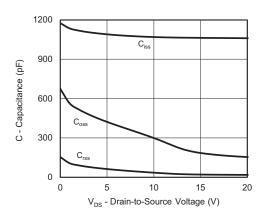
**Output Characteristics** 



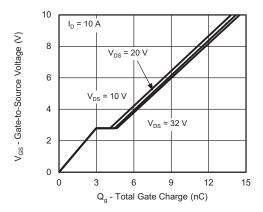
**Transfer Characteristics** 



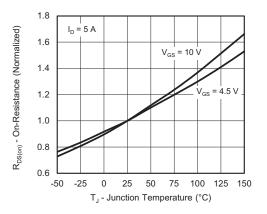
On-Resistance vs. Drain Current and Gate Voltage



Capacitance

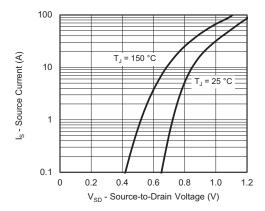


**Gate Charge** 

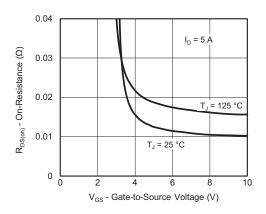


On-Resistance vs. Junction Temperature

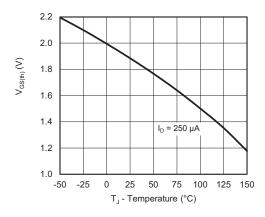




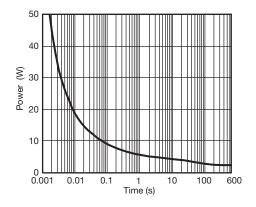
Source-Drain Diode Forward Voltage



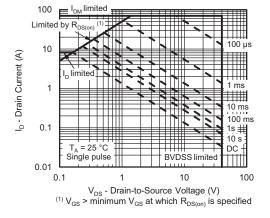
On-Resistance vs. Gate-to-Source Voltage



**Threshold Voltage** 

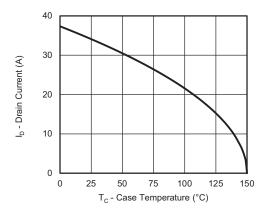


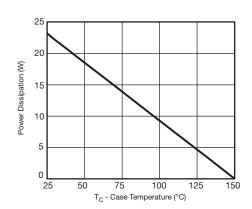
Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient







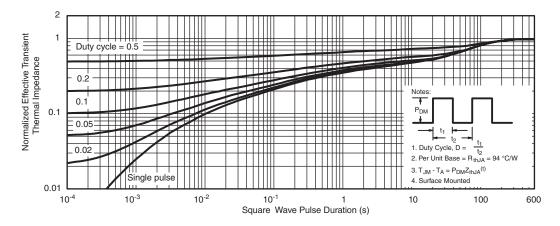
Current Derating a

### **Power Derating**

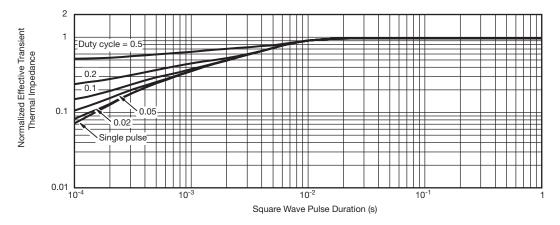
#### Note

a. The power dissipation P<sub>D</sub> is based on T<sub>J</sub> (max.) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





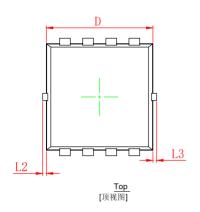
Normalized Thermal Transient Impedance, Junction-to-Ambient

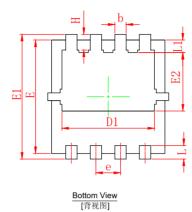


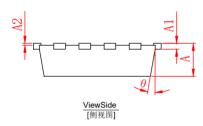
Normalized Thermal Transient Impedance, Junction-to-Case



## PDFNWB3×3-8L Package Outline Dimensions

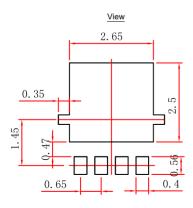






Symbol	Dimensions In I	Millimeters	Dimensions In Inches		
Symbol	Min	Max	Min	Max	
Α	0.650	0.850	0.026	0.033	
A1	0.203RE	F.	0.008REF.		
A2	0~0.0	5	0~0	.002	
D	2.900	3.100	0.114	0.122	
D1	2.050	2.550	0.081	0.100	
E	2.900	3.100	0.114	0.122	
E1	3.150	3.450	0.124	0.136	
E2	1.450	1.650	0.057	0.065	
b	0.200	0.400	0.008	0.016	
е	0.550	0.750	0.022	0.030	
L	0.300	0.500	0.012	0.020	
L1	0.180	0.480	0.007	0.019	
L2	0~0.100		0~0.004		
L3	0~0.100		0~0.004		
Н	0.315	0.515	0.012	0.020	
Φ	9°	13°	9°	13°	

## Suggested Pad Layout



#### Note:

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:±0.05mm.
- 3. The pad layout is for reference purposes only.



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